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L2	622	1 and registrat\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/11 16:10
L3	98	2 and segment and coordinat\$3 and angle and direct\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/11 16:11
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L7	26	6 and @ad<"20010129"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/11 16:14

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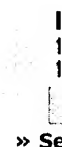
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1 Pen-based visitor registration system (PENGUIN)
Matic, N.; Henderson, D.; Le Cun, Y.; Bengio, Y.;

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[\[Abstract\]](#) [\[PDF Full-Text \(444 KB\)\]](#) **IEEE CNF**
2 Logo and word matching using a general approach to signal registra
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5 Design of an automated data entry system for hand-filled forms

Lin Woan Ning; Yap Keem Siah; Khalid, M.; Yusof, M.;

TENCON 2000. Proceedings , Volume: 1 , 24-27 Sept. 2000

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